Form PTO 1449 (Modified)		U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE		ATTY DOCKET NO. YONE3022/JJC/PMB		SERIAL NO. 10/572,575			
LIST OF REPERENCES SITED BY APPLICANT			APPLICANT  Keitaro YONEZAWA et al.						
LIST OF REFERENCES OTED BY APPLICANT			FILING DATE		GROUP				
	20 15 3008			March 17, 2006		3632			
U.S. PATENT DOCUMENTS  EXAMINER INITIAL NAME CLASS SUB CLASS IF APPROPRIATE  A 1 0 005 500 CASS VONEZAWA									
EXAMINER INITIAL	To TH	UMENT NUMBER	DATE	NAME	CLASS	SUB CLASS			
	AA	6,095,509	1 Aug 2000	YONEZAWA					
	AB	6,527,266	4 Mar 2003	YONEZAWA et al.					
	AC								
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	FOREIGN PATENT DOCUMENTS								
		DOCUMENT NUMBER	DATE	COUNTRY		TRANSLATION YES NO			
	AO	JP 48-96577	1973			<u> </u>			
	AP	JP 5-172119	7 Sept 1993			<u> </u>		x	
	AQ	JP 9-229837	5 Sept 1997			<del> </del>		x	
	AR	JP 11-188551	13 Jul 1999	<u> </u>				X	
	AS	JP 3338669	9 Aug 2002	JAPAN (with English Abstract)		<del>                                     </del>		<u> </u>	
	AT					<del>                                     </del>			
	AU		<u> </u>			<del>                                     </del>			
	AV		1			<u> </u>			
OTHER REFERENCES (Including Author, Title, Date, Pertinent Pages, etc.)									
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	AY								
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Examiner						Date Considered			
*Examiner: Initial if reference is considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.									